

54F/74F151A 8-Input Multiplexer

General Description

The 'F151A is a high-speed 8-input digital multiplexer. It provides in one package the ability to select one line of data from up to eight sources. The 'F151A can be used as a

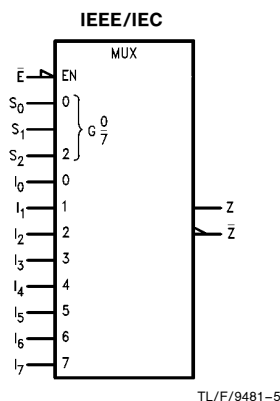
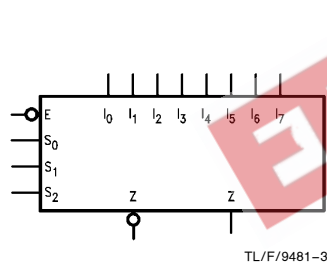
universal function generator to generate any logic function of four variables. Both assertion and negation outputs are provided.

Commercial	Military	Package Number	Package Description
74F151APC		N16E	16-Lead (0.300" Wide) Molded Dual-In-Line
	54F151ADM (Note 2)	J16A	16-Lead Ceramic Dual-In-Line
74F151ASC (Note 1)		M16A	16-Lead (0.150" Wide) Molded Small Outline, JEDEC
74F151ASJ (Note 1)		M16D	16-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F151AFM (Note 2)	W16A	16-Lead Cerpack
	54F151ALM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

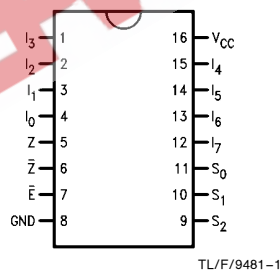
Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DQMB, FMQB and LMQB.

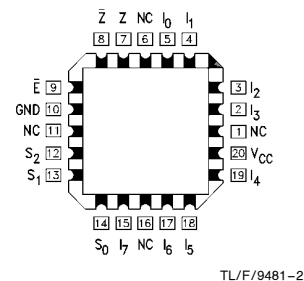
Logic Symbols



Pin Assignment for DIP,
SOIC and Flatpak



Pin Assignment
for LCC



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Unit Loading/Fan Out

Pin Names	Description	54F/74F	
		U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
I_0-I_7	Data Inputs	1.0/1.0	20 μ A/ -0.6 mA
S_0-S_2	Select Inputs	1.0/1.0	20 μ A/ -0.6 mA
$\bar{E}$	Enable Input (Active LOW)	1.0/1.0	20 μ A/ -0.6 mA
Z	Data Output	50/33.3	-1 mA/20 mA
$\bar{Z}$	Inverted Data Output	50/33.3	-1 mA/20 mA

Functional Description

The 'F151A is a logic implementation of a single pole, 8-position switch with the switch position controlled by the state of three Select inputs, S_0 , S_1 , S_2 . Both assertion and negation outputs are provided. The Enable input ($\bar{E}$) is active LOW. When it is not activated, the negation output is HIGH and the assertion output is LOW regardless of all other inputs. The logic function provided at the output is:

$$Z = \bar{E} \cdot (I_0 \bar{S}_2 \bar{S}_1 \bar{S}_0 + I_1 \bar{S}_2 \bar{S}_1 S_0 + I_2 \bar{S}_2 S_1 \bar{S}_0 + I_3 \bar{S}_2 S_1 S_0 + I_4 S_2 \bar{S}_1 \bar{S}_0 + I_5 S_2 \bar{S}_1 S_0 + I_6 S_2 S_1 \bar{S}_0 + I_7 S_2 S_1 S_0)$$

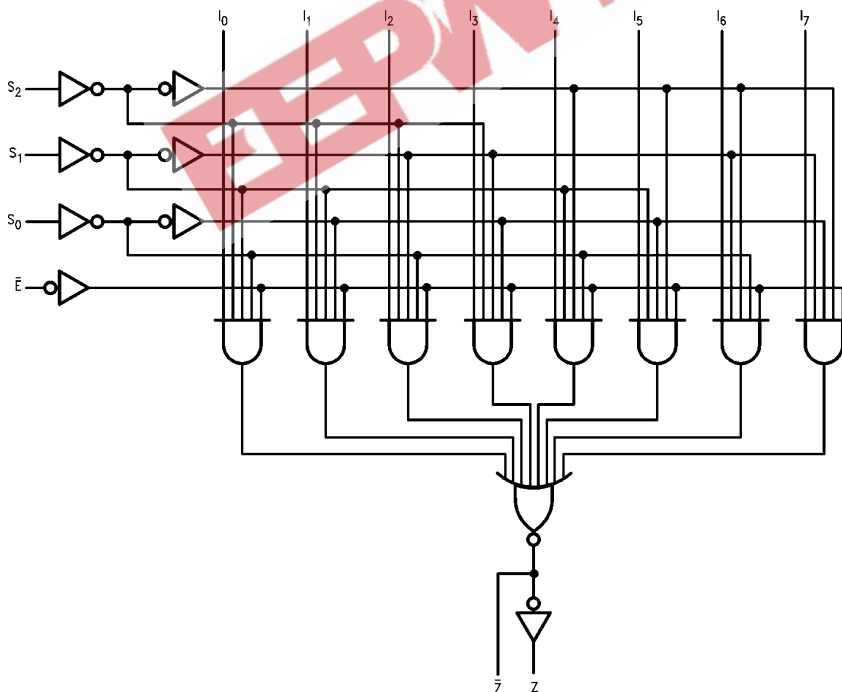
The 'F151A provides the ability, in one package, to select from eight sources of data or control information. By proper manipulation of the inputs, the 'F151A can provide any logic function of four variables and its negation.

Truth Table

Inputs				Outputs	
$\bar{E}$	S_2	S_1	S_0	$\bar{Z}$	Z
H	X	X	X	H	L
L	L	L	L	$\bar{I}_0$	I_0
L	L	L	H	$\bar{I}_1$	I_1
L	L	H	L	$\bar{I}_2$	I_2
L	L	H	H	$\bar{I}_3$	I_3
L	H	L	L	$\bar{I}_4$	I_4
L	H	L	H	$\bar{I}_5$	I_5
L	H	H	L	$\bar{I}_6$	I_6
L	H	H	H	$\bar{I}_7$	I_7

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

Logic Diagram



TL/F/9481-4

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature	−65°C to +150°C
Ambient Temperature under Bias	−55°C to +125°C
Junction Temperature under Bias	−55°C to +175°C
Plastic	−55°C to +150°C
V _{CC} Pin Potential to Ground Pin	−0.5V to +7.0V
Input Voltage (Note 2)	−0.5V to +7.0V
Input Current (Note 2)	−30 mA to +5.0 mA
Voltage Applied to Output in HIGH State (with V _{CC} = 0V)	
Standard Output	−0.5V to V _{CC}
TRI-STATE® Output	−0.5V to +5.5V
Current Applied to Output in LOW State (Max)	twice the rated I _{OL} (mA)

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature	
Military	−55°C to +125°C
Commercial	0°C to +70°C
Supply Voltage	
Military	+4.5V to +5.5V
Commercial	+4.5V to +5.5V

DC Electrical Characteristics

Symbol	Parameter	54F/74F			Units	V _{CC}	Conditions
		Min	Typ	Max			
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage			−1.2	V	Min	I _{IN} = −18 mA
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC}	2.5 2.5 2.7		V	Min	I _{OH} = −1 mA I _{OH} = −1 mA I _{OH} = −1 mA
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}		0.5 0.5	V	Min	I _{OL} = 20 mA I _{OL} = 20 mA
I _{IH}	Input HIGH Current	54F 74F		20.0 5.0	μA	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F		100 7.0	μA	Max	V _{IN} = 7.0V
I _{CEX}	Output HIGH Leakage Current	54F 74F		250 50	μA	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test	74F	4.75		V	0.0	I _{ID} = 1.9 μA All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current	74F		3.75	μA	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current			−0.6	mA	Max	V _{IN} = 0.5V
I _{OS}	Output Short-Circuit Current		−60	−150	mA	Max	V _{OUT} = 0V
I _{CC}	Power Supply Current		13.5	21.0	mA	Max	V _O = HIGH

AC Electrical Characteristics

Symbol	Parameter	74F			54F		74F		Units
		$T_A = +25^{\circ}\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50\text{ pF}$			$T_A, V_{CC} = \text{Mil}$ $C_L = 50\text{ pF}$		$T_A, V_{CC} = \text{Com}$ $C_L = 50\text{ pF}$		
		Min	Typ	Max	Min	Max	Min	Max	
t_{PLH} t_{PHL}	Propagation Delay S_n to $\bar{Z}$	4.0 3.2	6.2 5.2	9.0 7.5	3.5 3.0	11.5 8.0	3.5 3.2	9.5 7.5	ns
t_{PLH} t_{PHL}	Propagation Delay S_n to Z	4.5 4.0	7.5 6.2	10.5 9.0	4.5 4.0	13.5 9.5	4.5 4.0	12.0 9.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\bar{E}$ to $\bar{Z}$	3.0 3.0	4.7 4.4	6.1 6.0	3.0 2.5	7.5 6.5	3.0 2.5	7.0 6.0	ns
t_{PLH} t_{PHL}	Propagation Delay $\bar{E}$ to Z	5.0 3.5	7.0 5.3	9.5 7.0	4.0 3.0	12.0 8.0	4.0 3.0	10.5 7.5	ns
t_{PLH} t_{PHL}	Propagation Delay I_n to $\bar{Z}$	3.0 1.5	4.8 2.5	6.5 4.0	2.5 1.5	7.5 6.0	3.0 1.5	7.0 5.0	ns
t_{PLH} t_{PHL}	Propagation Delay I_n to Z	3.0 3.7	4.8 5.5	6.5 7.0	2.5 3.5	8.5 9.0	2.5 3.7	7.5 7.5	ns

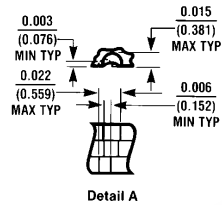
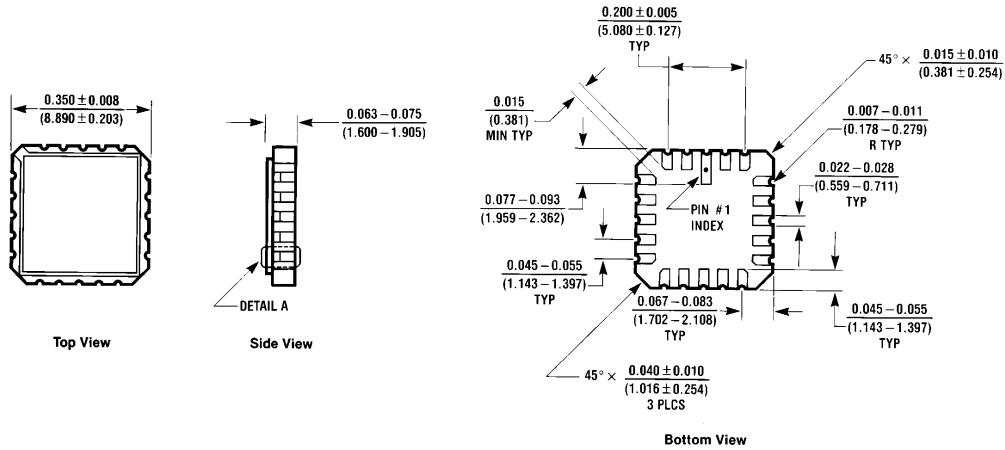
Ordering Information

Temperature Range Family ———— 74F 151A S C X
 74F = Commercial
 54F = Military
 Device Type ————
 Package Code ————
 P = Plastic DIP
 D = Ceramic DIP
 F = Flatpak
 L = Leadless Chip Carrier (LCC)
 S = Small Outline SOIC JEDEC
 SJ = Small Outline SOIC EIAJ

Special Variations
 CB = Military grade device with environmental and burn-in processing
 X = Devices shipped in 13" reel

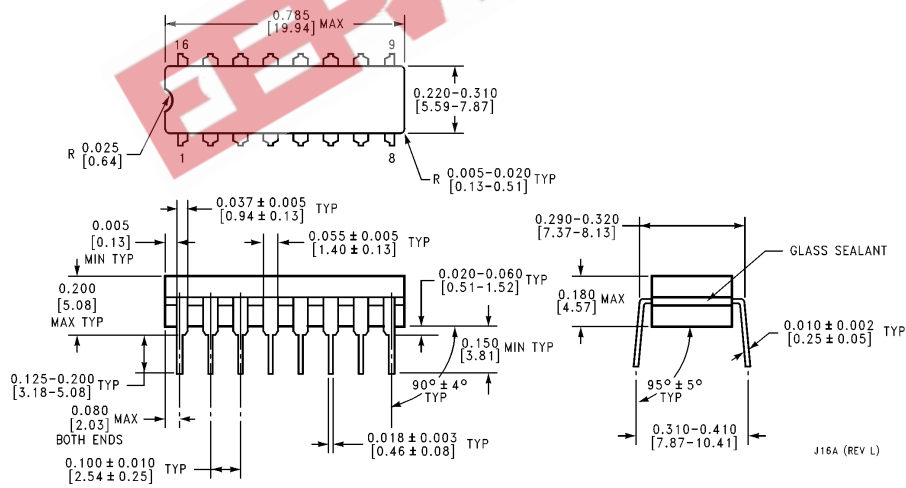
Temperature Range
 C = Commercial (0°C to +70°C)
 M = Military (−55°C to +125°C)

Physical Dimensions inches (millimeters)



20-Lead Ceramic Leadless Chip Carrier (L)
NS Package Number E20A

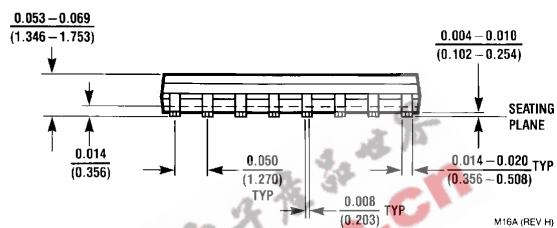
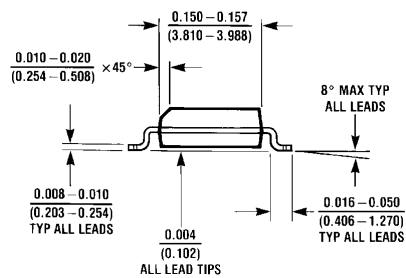
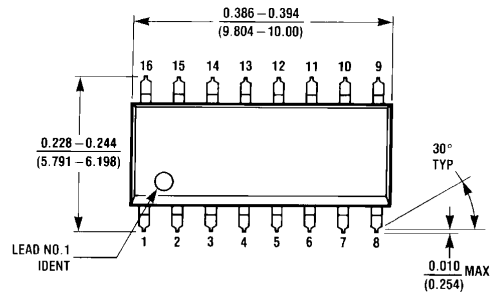
E20A (REV D)



16-Lead Ceramic Dual In-Line Package (D)
NS Package Number J16A

J16A (REV L)

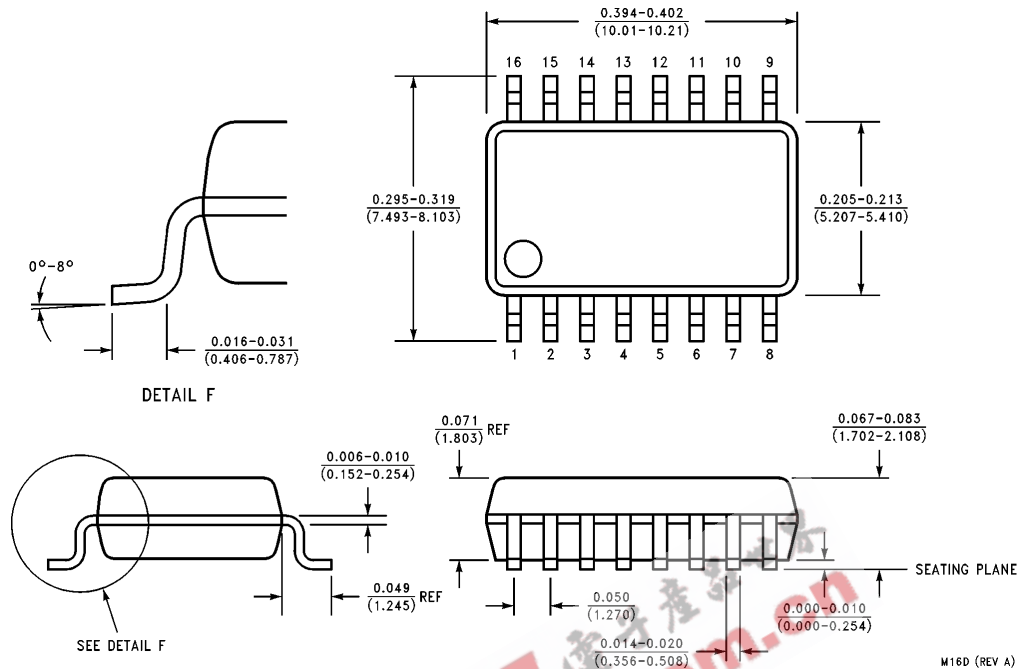
Physical Dimensions inches (millimeters) (Continued)



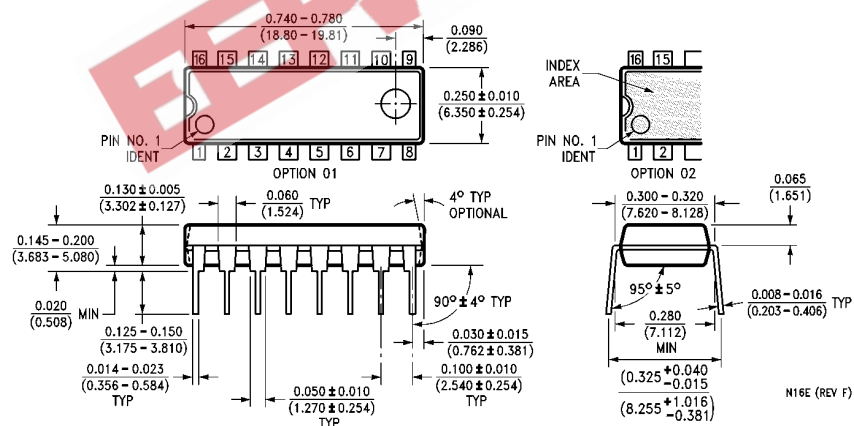
16-Lead (0.150" Wide) Molded Small Outline Package, JEDEC (S)
NS Package Number M16A

M16A (REV H)

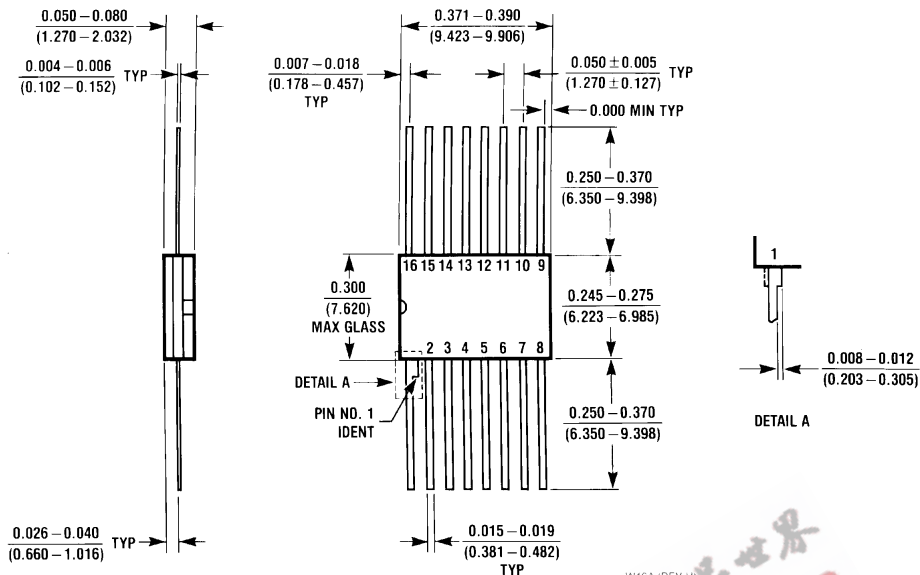
Physical Dimensions inches (millimeters) (Continued)



16-Lead (0.300" Wide) Molded Small Outline Package, EIAJ (SJ)
NS Package Number M16D



16-Lead (0.300" Wide) Molded Dual In-Line Package (P)
NS Package Number N16E

Physical Dimensions inches (millimeters) (Continued)

16-Lead Ceramic Flatpak (F)
NS Package Number W16A

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